

# GSMDB2116SFF

## 20V N+P Dual Channel MOSFETs

### Product Description

These N+P dual Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency fast switching applications.

### Features

- N-Channel  
20V, 5A,  $R_{DS(ON)}=40m\Omega$ @ $V_{GS}=4.5V$
- P-Channel  
-20V, -4.7A,  $R_{DS(ON)}=95m\Omega$ @ $V_{GS}=-4.5V$
- Fast switching
- Suit for -1.8V/1.8V Gate Drive Applications
- Green Device Available
- DFN2X2-6L(B) package design

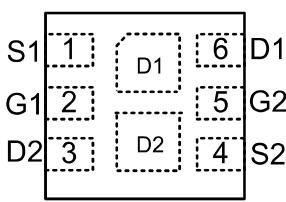
### Applications

- Notebook
- Load Switch
- Networking
- Hand-held Instruments

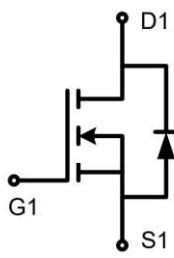
### Packages & Pin Assignments

GSMDB2116SFF (DFN2X2-6L(B))	
Pin	Description
1	Source 1
2	Gate 1
3	Drain 2
4	Source 2
5	Gate 2
6	Drain 1

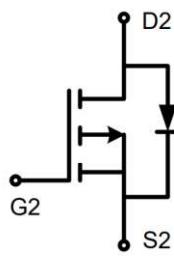
Top Views



n-channel

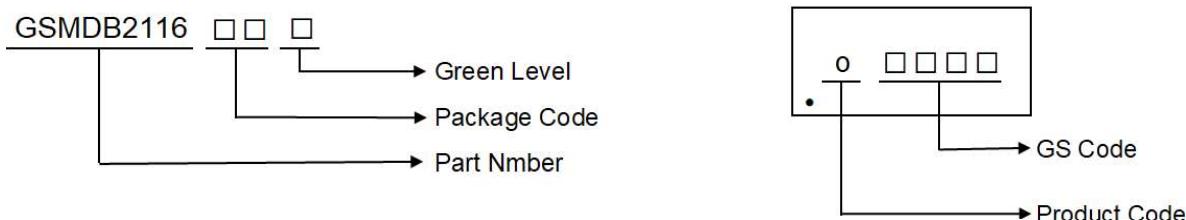


p-channel



## Ordering and Marking Information

Part Number	Package	Marking	Quantity
GSMDB2116SFF	DFN2X2-6L(B)	○□□□□	4000pcs



- Package Code  
SF: DFN2x2-6L(B)
- Green Level  
F: RoHS and Halogen Free

## Absolute Maximum Ratings

T<sub>C</sub>=25°C Unless otherwise noted

Symbol	Parameter	Typical		Unit	
		N-Channel	P-Channel		
V <sub>DS</sub>	Drain-Source Voltage	20	-20	V	
V <sub>GS</sub>	Gate-Source Voltage	±10	±10	V	
I <sub>D</sub>	Continuous Drain Current(T <sub>J</sub> =150°C)	T <sub>c</sub> =25°C T <sub>c</sub> =100°C	5 4.1	-4.7 -3.9	A
I <sub>DM</sub>	Pulsed Drain Current (Note 1)		15.2	-10	A
P <sub>D</sub>	Power Dissipation	T <sub>c</sub> =25°C Derate above 25°C	1.56 0.01	W W/°C	
T <sub>J</sub>	Operating Junction Temperature Range		-55 to +150	°C	
T <sub>STG</sub>	Storage Temperature Range		-55 to +150	°C	
R <sub>θJA</sub>	Thermal Resistance-Junction to Ambient		80	°C/W	
R <sub>θJC</sub>	Thermal Resistance-Junction to Case		15	°C/W	

Note 1: Repetitive Rating: Pulsed width limited by maximum junction temperature.

## Electrical Characteristics (N-Channel)

T<sub>J</sub>=25°C Unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
<b>Static</b>							
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	20			V	
△BV <sub>DSS</sub> /△T <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =1mA		0.02		V/°C	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	0.3	0.6	1.0	V	
△V <sub>GS(th)</sub>	V <sub>GS(th)</sub> Temperature Coefficient			-2		mV/°C	
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±10V			±100	nA	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V			1	uA	
		V <sub>DS</sub> =16V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C			10		
I <sub>S</sub>	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current			5	A	
I <sub>SM</sub>	Pulsed Source Current				10		
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A	30	40		mΩ	
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =2A	42	55			
		V <sub>GS</sub> =1.8V, I <sub>D</sub> =1.5A	55	70			
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =2A		4.4		S	
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =1A			1	V	
<b>Dynamic</b>							
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =10V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A		5.8	10	nC	
Q <sub>gs</sub>	Gate-Source Charge			0.6	1.5		
Q <sub>gd</sub>	Gate-Drain Charge			1.5	3		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz		315	600	pF	
C <sub>oss</sub>	Output Capacitance			50	80		
C <sub>rss</sub>	Reverse Transfer Capacitance			40	60		
t <sub>d(on)</sub>	Turn-On Time (Note 2,3)	V <sub>DD</sub> =10V, I <sub>D</sub> =1A, V <sub>GS</sub> =4.5V, R <sub>G</sub> =25Ω		2.9	6	ns	
t <sub>r</sub>				8.4	16		
t <sub>d(off)</sub>	Turn-Off Time (Note 2,3)			19.2	38		
t <sub>f</sub>				5.6	12		

Note 2: The data tested by pulsed, pulse width≤300μs, duty cycle≤2%.

Note 3: Essentially independent of operating temperature.

## Electrical Characteristics (P-Channel)

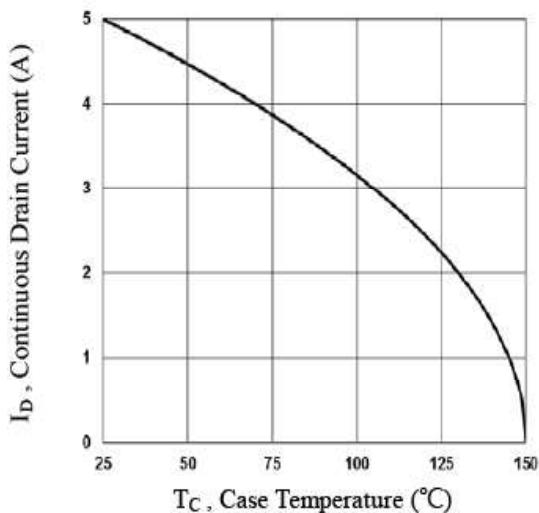
T<sub>J</sub>=25°C Unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
<b>Static</b>							
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA	-20			V	
△BV <sub>DSS</sub> /△T <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =-1mA		-0.01		V/°C	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-0.3	-0.6	-1.0	V	
△V <sub>GS(th)</sub>	V <sub>GS(th)</sub> Temperature Coefficient			3		mV/°C	
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±10V			±100	nA	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0V			-1	uA	
		V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C			-10		
I <sub>S</sub>	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current			-4.7	A	
I <sub>SM</sub>	Pulsed Source Current				-9.4		
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3A	80	95		mΩ	
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-2A	109	125			
		V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-1A	148	161			
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =-10V, I <sub>D</sub> =-1A	2.2			S	
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =-1A			-1	V	
<b>Dynamic</b>							
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =-10V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-2A		4.8	10	nC	
Q <sub>gs</sub>	Gate-Source Charge			0.5	1		
Q <sub>gd</sub>	Gate-Drain Charge			1.9	4		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f=1MHz		350	510	pF	
C <sub>oss</sub>	Output Capacitance			65	95		
C <sub>rss</sub>	Reverse Transfer Capacitance			50	75		
t <sub>d(on)</sub>	Turn-On Time (Note 2,3)	V <sub>DD</sub> =-10V, I <sub>D</sub> =-1A, V <sub>GS</sub> =-4.5V, R <sub>G</sub> =25Ω		3.5	7	ns	
t <sub>r</sub>				12.6	24		
t <sub>d(off)</sub>	Turn-Off Time (Note 2,3)			32.6	62		
t <sub>f</sub>				8.4	16		

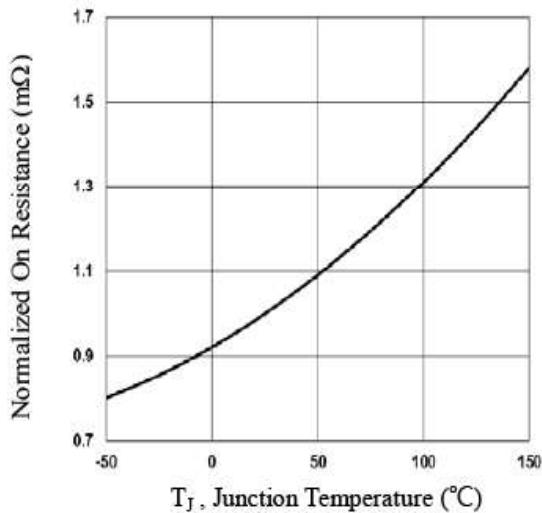
Note 2: The data tested by pulsed, pulse width  $\leq$  300μs, duty cycle  $\leq$  2%.

Note 3: Essentially independent of operating temperature.

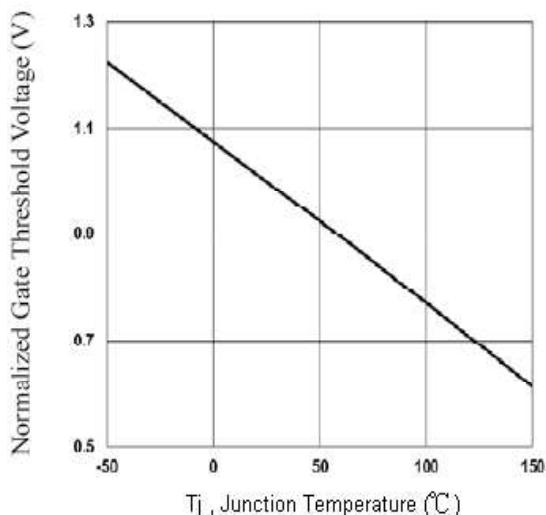
## Typical Performance Characteristics (N-Channel)



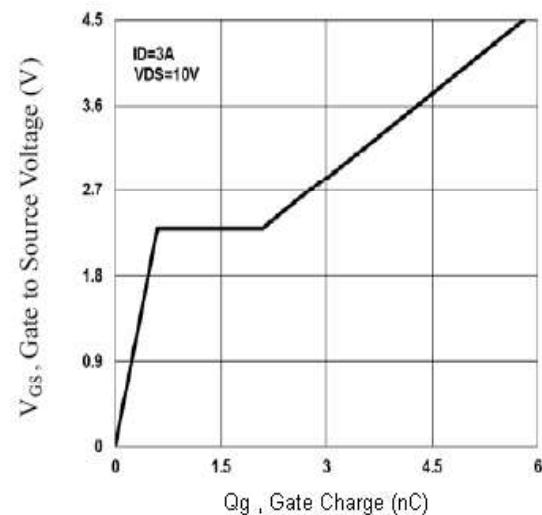
**Fig.1** Continuous Drain Current vs.  $T_c$



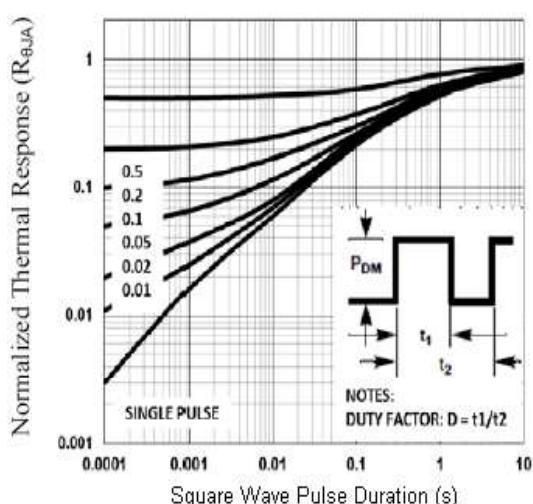
**Fig.2** Normalized RDS(on) vs.  $T_j$



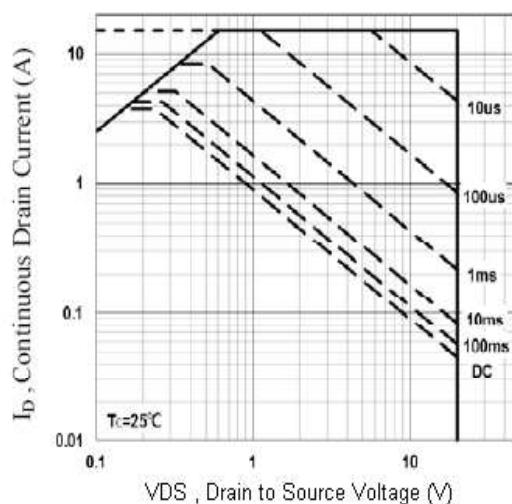
**Fig.3** Normalized  $V_{th}$  vs.  $T_j$



**Fig.4** Gate Charge Waveform



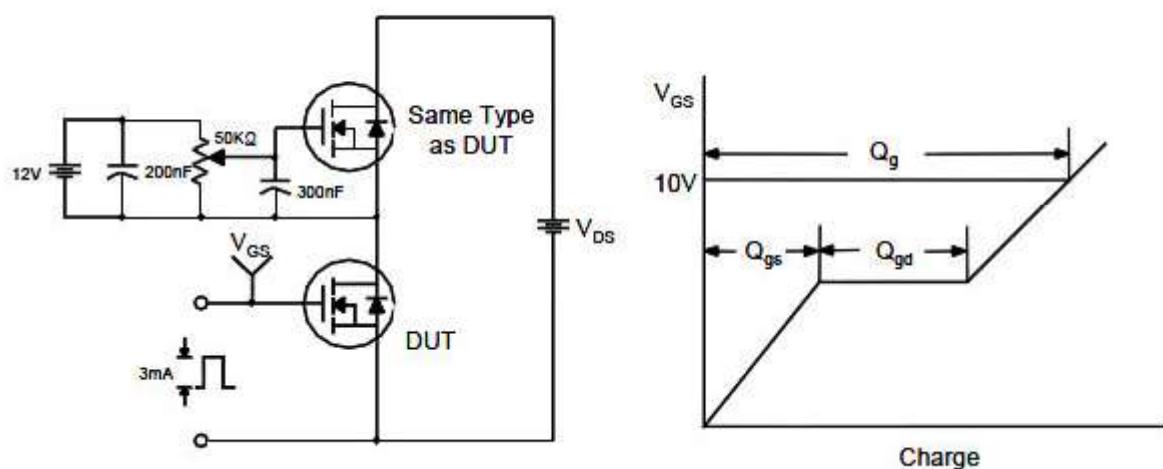
**Fig.5** Normalized Transient Impedance



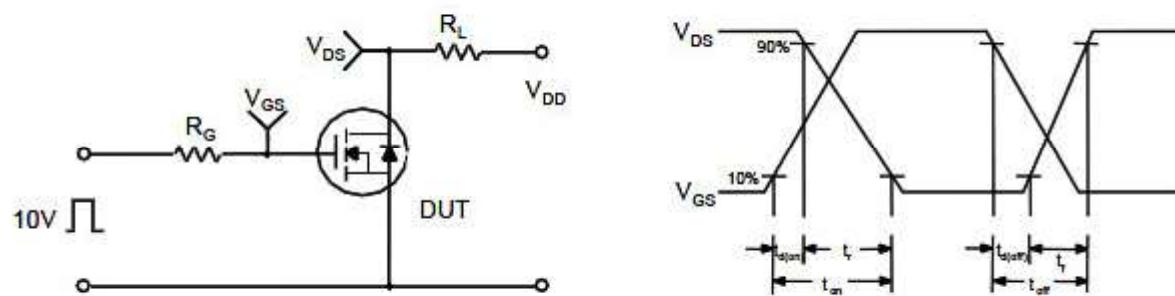
**Fig.6** Maximum Safe Operation Area

## Typical Performance Characteristics (N-Channel)

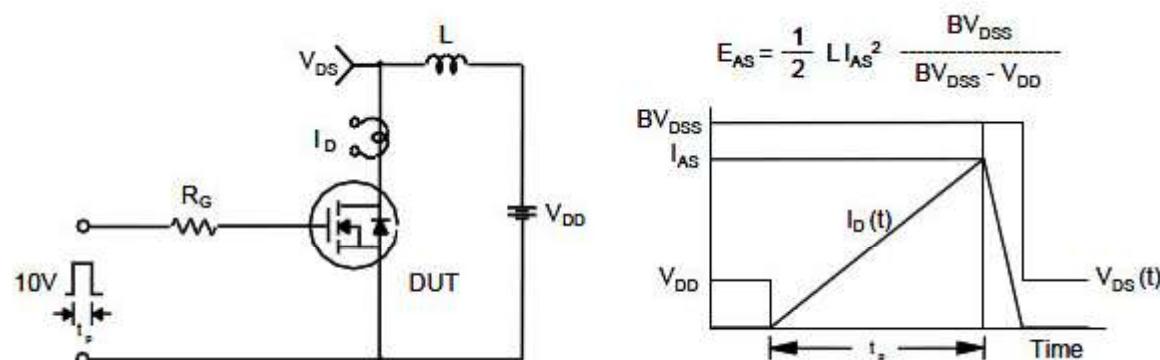
Gate Charge Test Circuit & Waveform



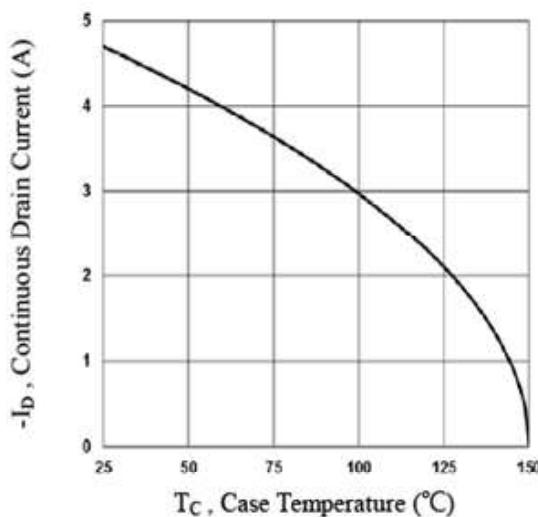
Resistive Switching Test Circuit & Waveforms



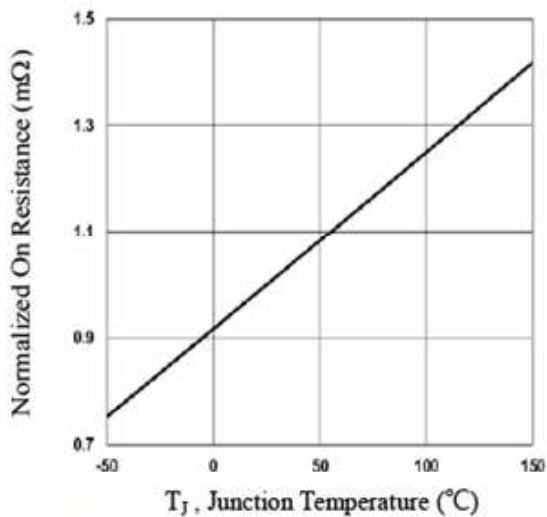
Unclamped Inductive Switching Test Circuit & Waveforms



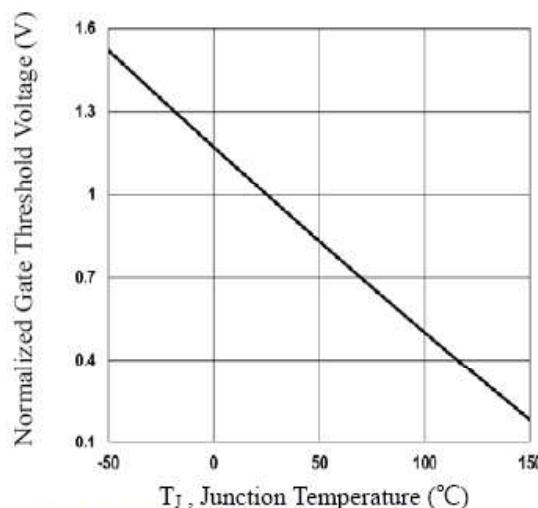
### Typical Performance Characteristics (P-Channel)



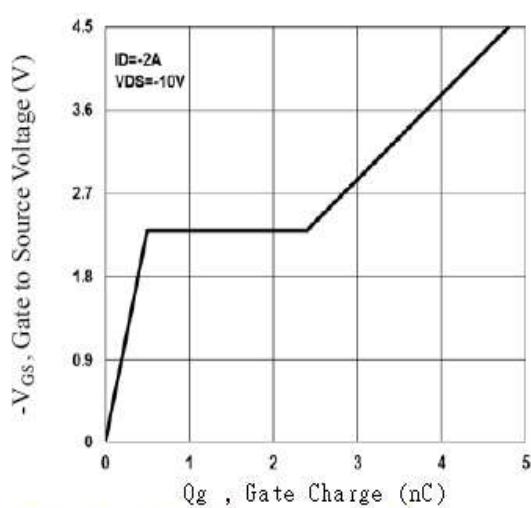
**Fig.7** Continuous Drain Current vs.  $T_C$



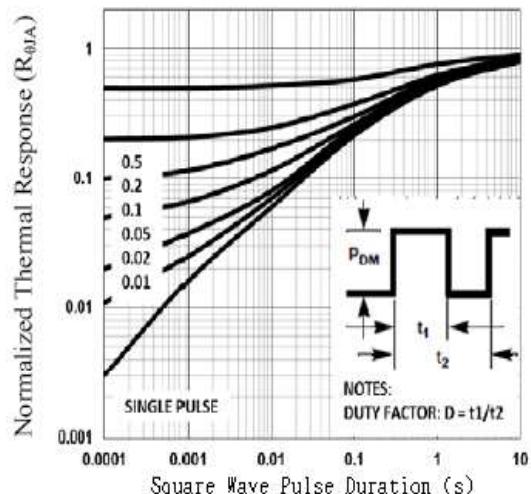
**Fig.8** Normalized RDSON vs.  $T_J$



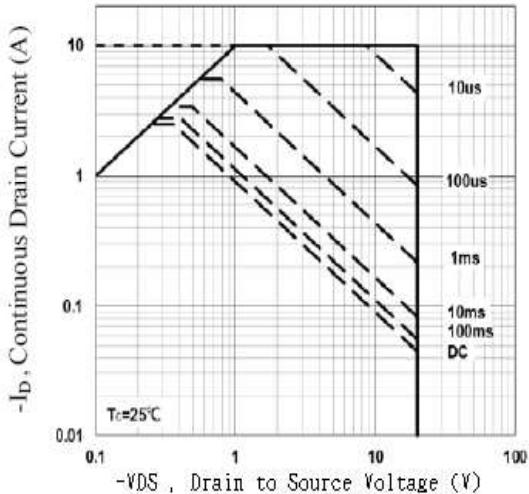
**Fig.9** Normalized  $V_{th}$  vs.  $T_J$



**Fig.10** Gate Charge Waveform



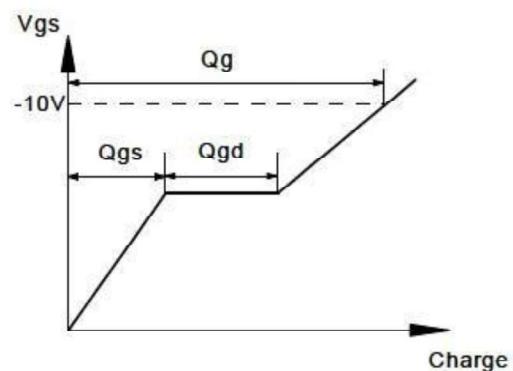
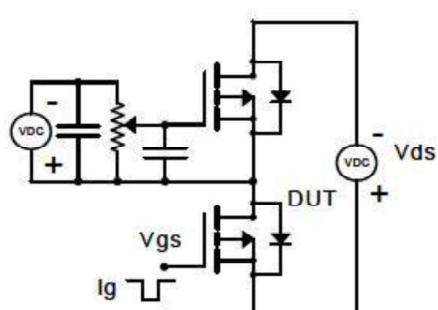
**Fig.11** Normalized Transient Impedance



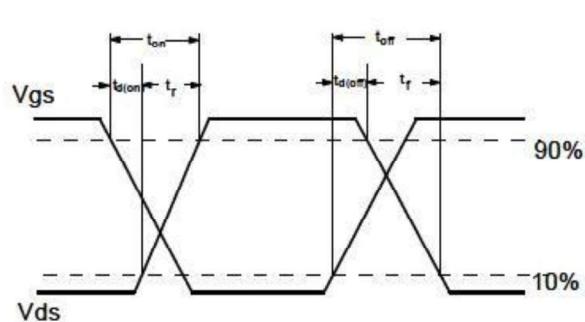
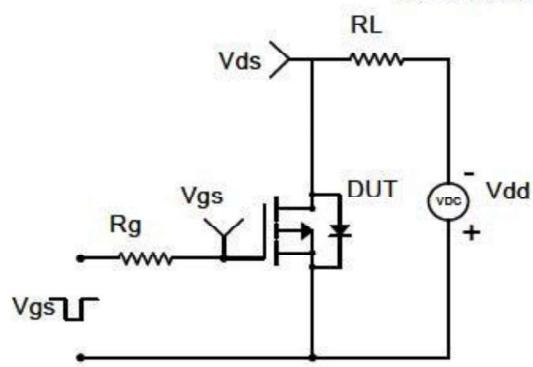
**Fig.12** Maximum Safe Operation Area

## Typical Performance Characteristics (P-Channel)

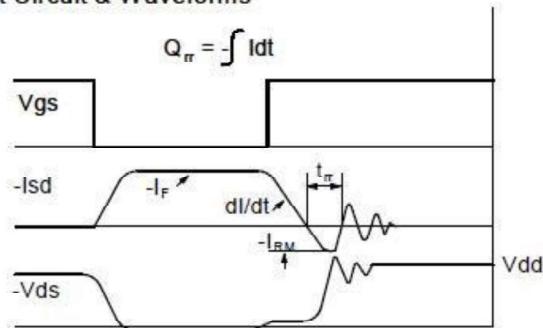
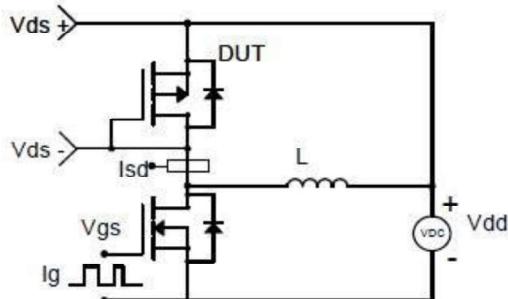
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

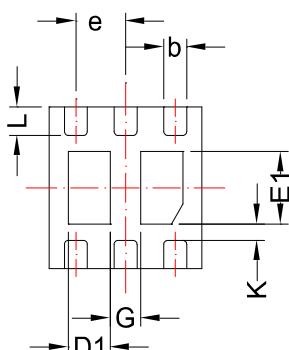
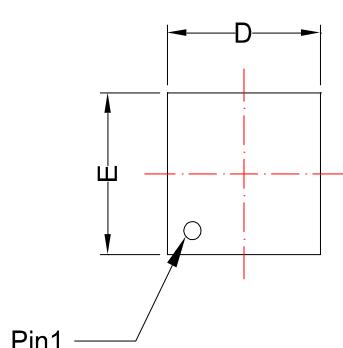


Diode Recovery Test Circuit & Waveforms

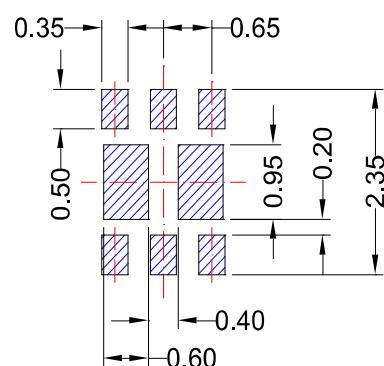


# DFN2X2-6L(B)

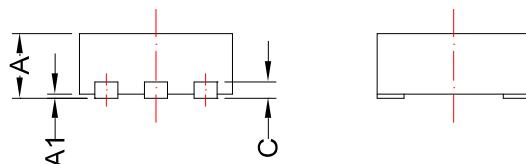
## Package Dimension



## Recommended Land Pattern



BACKSIDE VIEW



## Dimensions

SYMBOL	Millimeters		Inches	
	MIN	MAX	MIN	MAX
<b>A</b>	0.70	0.80	0.028	0.031
<b>A1</b>	0.00	0.05	0.000	0.002
<b>b</b>	0.23	0.33	0.009	0.013
<b>c</b>	0.203 REF		0.008 REF	
<b>D</b>	1.95	2.05	0.077	0.081
<b>D1</b>	0.50	0.60	0.020	0.024
<b>E</b>	1.95	2.05	0.077	0.081
<b>E1</b>	0.85	0.95	0.033	0.037
<b>e</b>	0.65 BSC		0.026 BSC	
<b>L</b>	0.27	0.37	0.011	0.015
<b>G</b>	0.40 BSC		0.016 BSC	
<b>K</b>	0.20 Min.		0.008 Min.	

NOTE:

DIMENSION D AND E DO NOT INCLUDE MOLD FLASH, TIE BAR BURRS, GATE BURRS, AND INTERLEAD FLASH, NOT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.

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